October 2004

ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3 EcoSPARK[™] 300mJ, 360V, N-Channel Ignition IGBT

General Description

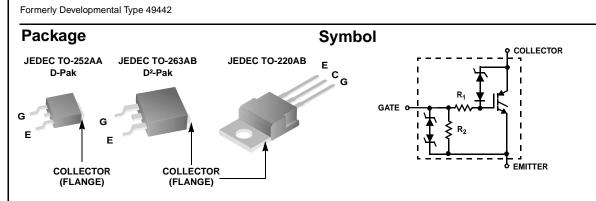
FAIRCHILD

Applications

- Automotive Ignition Coil Driver CircuitsCoil- On Plug Applications
- The ISL9V3036D3S, ISL9V3036S3S, and ISL9V3036P3 are the next generation IGBTs that offer outstanding SCIS capability in the space saving D-Pak (TO-252), as well as the industry standard D²-Pak (TO-263) and TO-220 plastic packages. These devices are intended for use in automotive ignition circuits, specifically as a coil drivers. Internal diodes provide voltage clamping without the need for external components.

EcoSPARK[™] devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

- Features
- Industry Standard D²-Pak package
- SCIS Energy = 300mJ at T_J = 25° C
- Logic Level Gate Drive

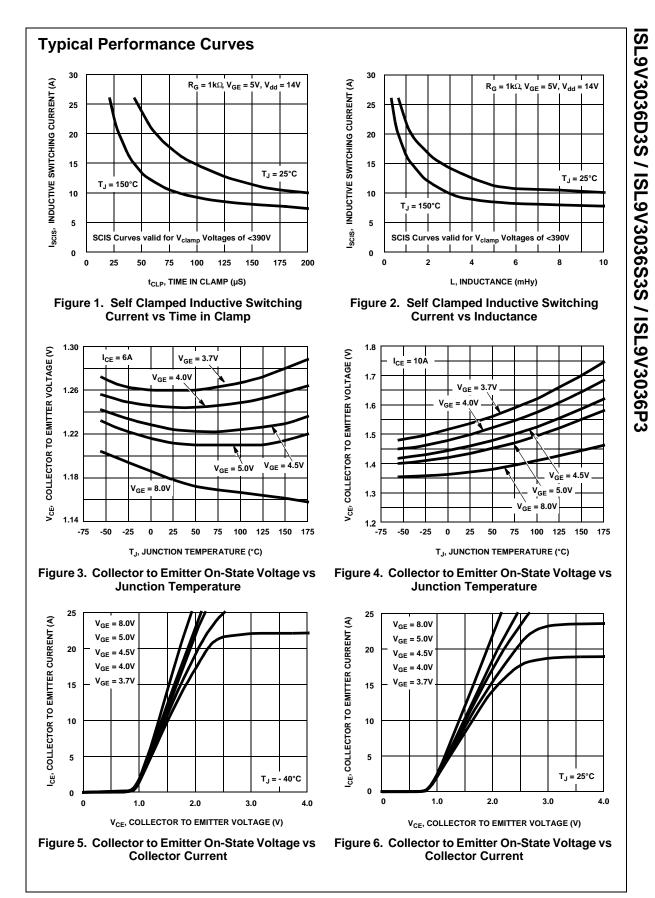


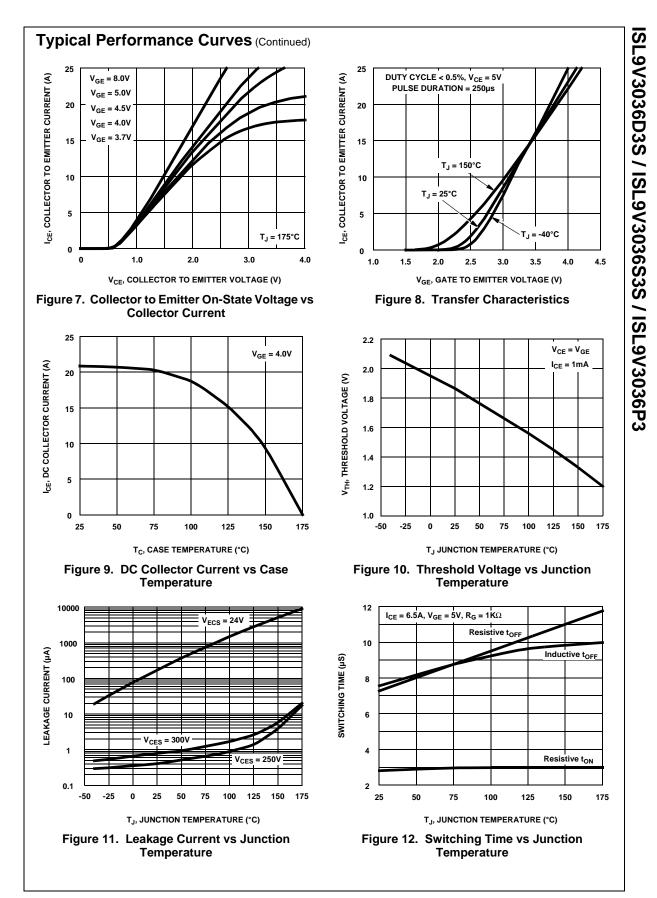
Device Maximum Ratings T_J = 25°C unless otherwise noted

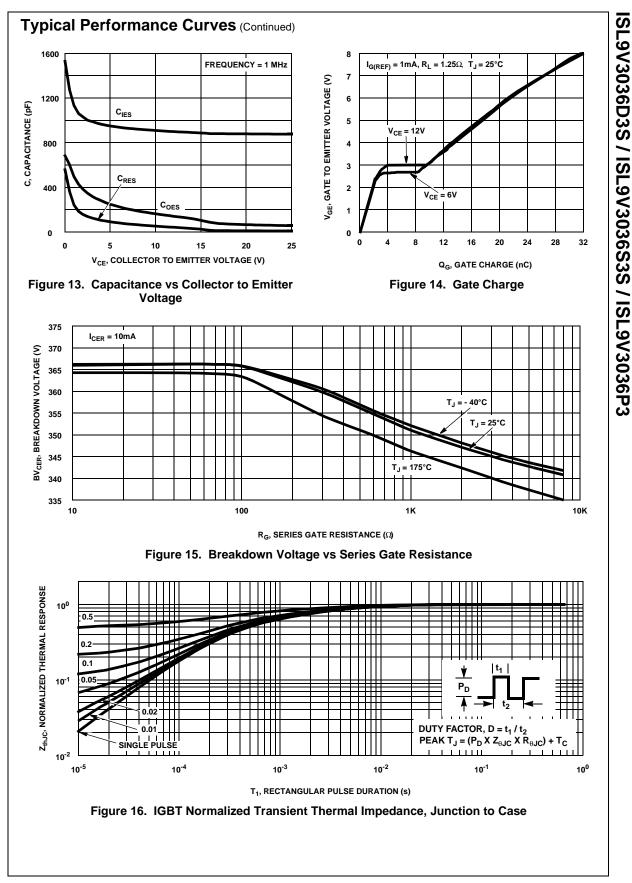
Symbol	Parameter	Ratings	
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	360	V
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = 10 mA)	24	V
E _{SCIS25}	T _J = 25°C, I _{SCIS} = 14.2A, L = 3.0 mHy	300	mJ
E _{SCIS150}	T _J = 150°C, I _{SCIS} = 10.6A, L = 3.0 mHy	170	mJ
I _{C25}	Collector Current Continuous, At T _C = 25°C, See Fig 9	21	Α
I _{C110}	Collector Current Continuous, At T _C = 110°C, See Fig 9	17	Α
V _{GEM}	Gate to Emitter Voltage Continuous	±10	V
PD	Power Dissipation Total $T_C = 25^{\circ}C$	150	W
	Power Dissipation Derating $T_{C} > 25^{\circ}C$	1.0	W/°C
TJ	Operating Junction Temperature Range	-40 to 175	°C
T _{STG}	Storage Junction Temperature Range	-40 to 175	°C
T _L Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)		300	°C
T _{pkg}	Max Lead Temp for Soldering (Package Body for 10s)	260	°C
ESD	ESD Electrostatic Discharge Voltage at 100pF, 1500Ω		kV

$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$		king	Device	Package	Reel Size	9	Tape	Width	G	luantity
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			330mm				İ	2500		
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	V3036S ISL9V3036S3ST TO-263AB		330mm		24mm			800		
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	V3036P ISL9V3036P3 TO-220AA		Tube		N/A			50		
lectrical CharacteristicsSymbolParameterTest ConditionsMinTypMaxUnitsff State Characteristics \mathbb{BV}_{CER} Collector to Emitter Breakdown Voltage $ _{C} = 2mA, V_{CE} = 0, R_G = 1K\Omega, See Fig. 15$ T_g = 40 to 150°C330360390V \mathbb{BV}_{CES} Collector to Emitter Breakdown Voltage $ _{C} = 10mA, V_{CE} = 0, R_G = 0, R_G = 0, R_G = 10, R_V = 0, R_G = 0, R_G = 10, R_V = 0, R_G = 10, R_G $	V3036D ISL9V3036D3S TO-252AA		Tube		N/A			75		
							1	N/A		50
$ ff State Characteristics \\ BV_{CER} Collector to Emitter Breakdown Voltage \begin{vmatrix} c = 2mA, V_{GE} = 0, \\ R_G = 1K\Omega, See Fig. 15 \\ T_J = 40 to 150^{\circ}C \\ \hline \\ BV_{CES} \\ \hline \\ Collector to Emitter Breakdown Voltage \\ c = 107A, V_{GE} = 0, \\ R_G = 0, See Fig. 15 \\ T_J = 40 to 150^{\circ}C \\ \hline \\ BV_{CES} \\ \hline \\ Ewitter to Collector Breakdown Voltage \\ c = 75mA, V_{GE} = 0, \\ R_G = 0, See Fig. 15 \\ T_J = 40 to 150^{\circ}C \\ \hline \\ BV_{CES} \\ \hline \\ Cellector to Emitter Breakdown Voltage \\ c = 8250V, \\ R_G = 1K\Omega \\ See Fig. 11 \\ \hline \\ T_C = 25^{\circ}C \\ \hline \\ \hline \\ CER \\ \hline \\ Cellector to Emitter Breakdown Voltage \\ c = 162, 225^{\circ}C \\ \hline \\ \hline \\ Cer \\ \hline \\ \hline \\ Cer \\ \hline \\ \hline \\ Cer \\ \hline \\ Cer \\ \hline \\ \hline \\ Ce$		al C					Min	Typ	Max	Units
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	-	Char			1631 0011	ultions	WIIII	тур	Max	Units
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $				akdown Voltage	$R_G = 1K\Omega$, See Fig. 15		330	360	390	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	BV _{CES}	Colle	Collector to Emitter Breakdown Voltage		$I_{C} = 10$ mA, $V_{GE} = 0$, R _G = 0, See Fig. 15		350	380	410	V
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	BV _{ECS}	Emit	Emitter to Collector Breakdown Voltage		I _C = -75mA, V _{GE} = 0V,		30	-	-	V
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	BV _{GES}	Gate	e to Emitter Breakdo	wn Voltage	$I_{GES} = \pm 2mA$		±12	±14	-	V
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	I _{CER}	Colle	ector to Emitter Lea	kage Current		-	-	-	25	μA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$						-	-	-	1	mA
R1Series Gate Resistance-70- Ω R2Gate to Emitter Resistance10K-26K Ω n State Characteristics $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 6A$, $V_{GE} = 4V$ $T_C = 25^{\circ}C$, See Fig. 3-1.251.60V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 10A$, $V_{GE} = 4.5V$ $T_C = 150^{\circ}C$, 	I _{ECS}	Emit	ter to Collector Lea	kage Current			-	-	1	mA
R2Gate to Emitter Resistance10K-26KΩn State Characteristics $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 6A$, $V_{GE} = 4V$ $T_C = 25^\circ C$, See Fig. 3-1.251.60V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 10A$, $V_{GE} = 4.5V$ $T_C = 150^\circ C$, See Fig. 4-1.581.80V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 10A$, $V_{GE} = 4.5V$ $T_C = 150^\circ C$, $V_{GE} = 4.5V$ -1.902.20Vynamic Characteristics $Q_{G(ON)}$ Gate to Emitter Threshold Voltage $I_C = 10A$, $V_{CE} = 12V$, $V_{CE} = 5V$, See Fig. 14-17-nC $V_{GE(TH)}$ Gate to Emitter Plateau Voltage $I_C = 10A$, $V_{CE} = V_{GE}$, $See Fig. 10-1.8VV_{GEP}Gate to Emitter Plateau VoltageI_C = 10A,V_{CE} = 14V, T_C = 150^\circ C0.75-1.8VV_{GEP}Gate to Emitter Plateau VoltageI_C = 10A,V_{CE} = 14V, R_L = 1\Omega,V_{CE} = 12V-3.0-Vwitching CharacteristicsV_{CE} = 14V, R_L = 1\Omega,V_{CE} = 5V, R_G = 1K\OmegaT_J = 25^\circ C, See Fig. 12-0.74\mu st_{(QON)R}Current Turn-On Delay Time-ResistiveT_J = 25^\circ C, See Fig. 12-2.815\mu st_{(CFF)L}Current Rise Time-ResistiveT_J = 25^\circ C, See Fig. 12-2.815\mu sSCISSelf Clamped Inductive Switching$					Fig. 11	T _C = 150°C	-	-	40	
State Characteristics $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 6A$, $V_{GE} = 4V$ $T_C = 25^{\circ}C$, See Fig. 3-1.251.60V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 10A$, $V_{GE} = 4.5V$ $T_C = 150^{\circ}C$, See Fig. 4-1.581.80V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 10A$, $V_{GE} = 4.5V$ $T_C = 150^{\circ}C$, See Fig. 4-1.581.80V $V_{CE(SAT)}$ Collector to Emitter Saturation Voltage $I_C = 15A$, $V_{GE} = 4.5V$ $T_C = 150^{\circ}C$ -1.902.20Vynamic Characteristics $\Omega_{G(ON)}$ Gate Charge $I_C = 10A$, $V_{CE} = 12V$, $V_{GE} = 5V$, See Fig. 14-17-nC $V_{GE(TH)}$ Gate to Emitter Threshold Voltage $I_C = 10mA$, $V_{CE} = V_{GE}$, See Fig. 10 $T_C = 25^{\circ}C$ 1.3-2.2V V_{GEP} Gate to Emitter Plateau Voltage $I_C = 10A$, $V_{CE} = 12V$, $V_{CE} = 10A$, $V_{CE} = 12V$ -1.8V V_{GEP} Gate to Emitter Plateau Voltage $I_C = 10A$, $V_{CE} = 12V$ -3.0-Vwitching Characteristics $V_{CE} = 10A$, $V_{CE} = 14V$, $R_L = 1\Omega$ -0.74 μs $t_{q(ON)R}$ Current Turn-On Delay Time-Resistive $V_{CE} = 14V$, $R_L = 1\Omega$ -0.74 μs $t_{q(OFF)L}$ Current Rise Time-Resistive $V_{CE} = 300V$, $R_L = 500\mu$, $R_L = 50\mu$, $R_L = 12V$ -		_				-	70	-		
$\begin{array}{ c c c c } \hline V_{CE}(sh) & V$				ration Voltage		See Fig. 3	-	1.25	1.60	V
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	V _{CE(SAT)}	Colle	ector to Emitter Satu	ration Voltage			-	1.58	1.80	V
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	V _{CE(SAT)}	Colle	ector to Emitter Satu	ration Voltage	-	T _C = 150°C	-	1.90	2.20	V
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	ynamic	Char	acteristics							
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Q _{G(ON)}	Gate	e Charge		I _C = 10A, V _{CE} = 12V, V _{GE} = 5V, See Fig. 14		-	17	-	nC
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{GE(TH)}	Gate	e to Emitter Thresho	old Voltage			1.3	-	2.2	
witching Characteristics $t_{d(ON)R}$ Current Turn-On Delay Time-Resistive $V_{CE} = 14V, R_L = 1\Omega$ -0.74 μs t_{rR} Current Rise Time-Resistive $V_{GE} = 5V, R_G = 1K\Omega$ -2.17 μs $t_{dOFF)L}$ Current Turn-Off Delay Time-Inductive $V_{CE} = 300V, R_L = 500\mu H,$ -4.815 μs t_{fL} Current Fall Time-Inductive $V_{GE} = 5V, R_G = 1K\Omega$ -2.815 μs t_{fL} ScISSelf Clamped Inductive Switching $T_J = 25^{\circ}C, See Fig. 12$ -300mJ					See Fig. 10	0	0.75	-	1.8	-
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V_{GEP}	Gate	e to Emitter Plateau	Voltage	I _C = 10A,	$V_{CE} = 12V$	-	3.0	-	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $						1.0		-	1	1
T_ICurrent Turn-Off Delay Time-InductiveT_J = 25°C, See Fig. 12Image: Constraint of the second sec							-			-
$ \begin{array}{c c} \hline t_{fL} & Current Fall Time-Inductive \\ \hline t_{fL} & Current Fall Time-Inductive \\ \hline t_{J} = 25^{\circ}C, See Fig. 12 \\ \hline SCIS & Self Clamped Inductive Switching \\ \hline T_{J} = 25^{\circ}C, L = 3.0 \text{ mH}, \\ \hline - & - & 300 \\ \hline mJ \\ \hline \end{array} $				T _J = 25°C, See Fig. 12		-				
TLTJ = 25°C, See Fig. 12SCISSelf Clamped Inductive SwitchingTJ = 25°C, L = 3.0 mH,300 mJ		-				-			-	
					T _J = 25°C, See Fig. 12					
	3013	Seif	Ciampeu muucuve	ownerning			-	-	300	IIIJ

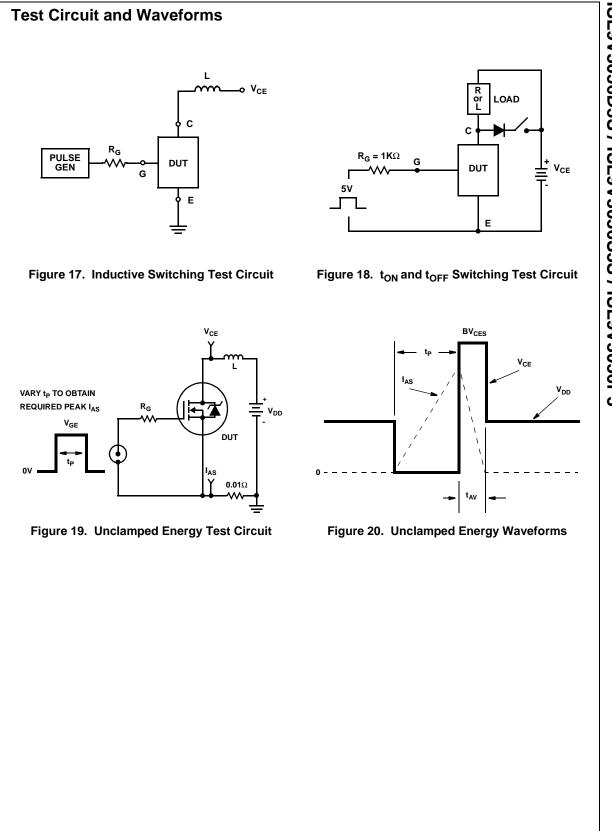
ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3 Rev. C3, October 2004



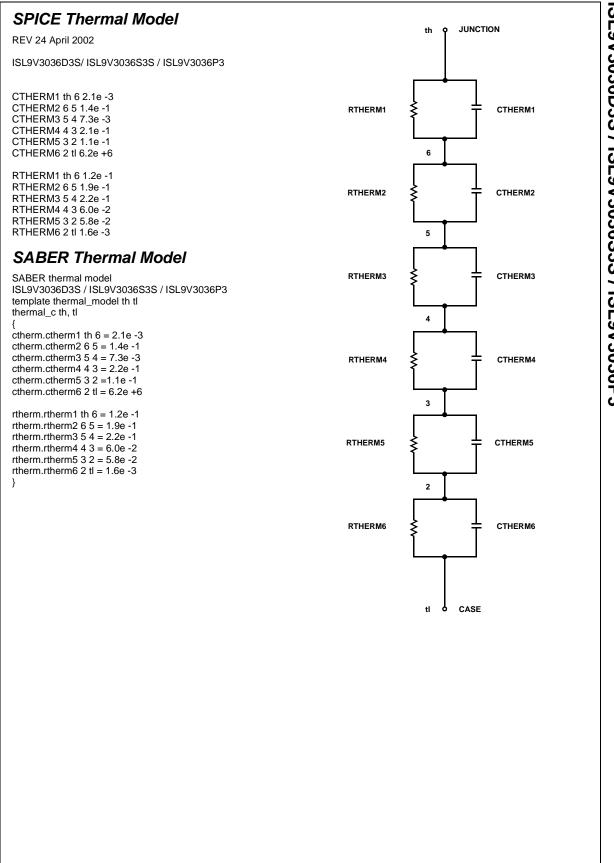




ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3 Rev. C3, October 2004



ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3



ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	FAST®	ISOPLANAR™	Power247™	Stealth™
ActiveArray™	FASTr™	LittleFET™	PowerEdge™	SuperFET™
Bottomless™	FPS™	MICROCOUPLER™	PowerSaver™	SuperSOT™-3
CoolFET™	FRFET™	MicroFET™	PowerTrench [®]	SuperSOT™-6
CROSSVOLT™	GlobalOptoisolator™	MicroPak™	QFET [®]	SuperSOT™-8
DOME™	GTO™	MICROWIRE™	QS™	SyncFET™
EcoSPARK™	HiSeC™	MSX™	QT Optoelectronics [™]	TinyLogic®
E ² CMOS [™]	I²C™	MSXPro™	Quiet Series [™]	TINYOPTO™
EnSigna™	<i>i-Lo</i> ™	OCX™	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
FACT Quiet Series [™]		OPTOLOGIC [®]	µSerDes™	UltraFET [®]
Across the board. Around the world. [™] The Power Franchise [®] Programmable Active Droop [™]		OPTOPLANAR™ PACMAN™ POP™	SILENT SWITCHER [®] SMART START™ SPM™	VCX™

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user. 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
		Rev. 113